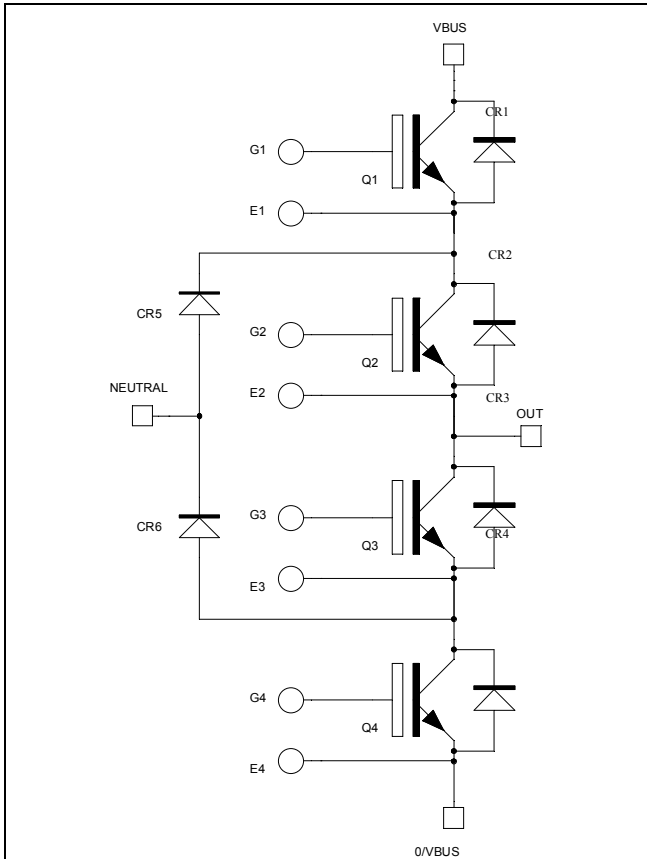


**Three level inverter  
Trench + Field Stop IGBT3  
Power Module**

$V_{CES} = 650V$   
 $I_C = 400A @ T_c = 80^\circ C$



**Application**

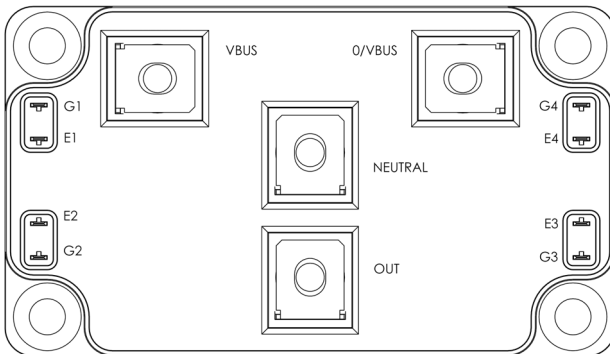
- Solar converter
- Uninterruptible Power Supplies

**Features**

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- M5 power connectors
- High level of integration

**Benefits**

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant



**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

**Q1 to Q4 Absolute maximum ratings** (per IGBT)

Symbol	Parameter	Max ratings	Unit
$V_{CES}$	Collector - Emitter Voltage	650	V
$I_C$	Continuous Collector Current	$T_C = 25^\circ\text{C}$	500
		$T_C = 80^\circ\text{C}$	400
$I_{CM}$	Pulsed Collector Current	$T_C = 25^\circ\text{C}$	800
$V_{GE}$	Gate - Emitter Voltage	$\pm 20$	V
$P_D$	Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	1150
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^\circ\text{C}$	800A @ 600V

**Q1 to Q4 Electrical Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$ , $V_{CE} = 650\text{V}$			250	$\mu\text{A}$
$V_{CE(sat)}$	Collector Emitter saturation Voltage	$V_{GE} = 15\text{V}$ $I_C = 400\text{A}$		1.5	1.9	V
		$T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$		1.7		
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 6.4\text{ mA}$	5.1	5.8	6.4	V
$I_{GES}$	Gate - Emitter Leakage Current	$V_{GE} = 20\text{V}$ , $V_{CE} = 0\text{V}$			1.2	$\mu\text{A}$

**Q1 to Q4 Dynamic Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0\text{V}$		24		nF
$C_{oes}$	Output Capacitance	$V_{CE} = 25\text{V}$		1.5		
$C_{res}$	Reverse Transfer Capacitance	$f = 1\text{MHz}$		0.75		
$Q_G$	Gate charge	$V_{GE} = \pm 15\text{V}$ , $I_C = 400\text{A}$ $V_{CE} = 300\text{V}$		4.2		$\mu\text{C}$
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $25^\circ\text{C}$ ) $V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 400\text{A}$ $R_G = 1.8\Omega$		115		ns
$T_r$	Rise Time			45		
$T_{d(off)}$	Turn-off Delay Time			225		
$T_f$	Fall Time			55		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $150^\circ\text{C}$ ) $V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 400\text{A}$ $R_G = 1.8\Omega$		130		ns
$T_r$	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			300		
$T_f$	Fall Time			70		
$E_{on}$	Turn on Energy	$V_{GE} = \pm 15\text{V}$ $V_{Bus} = 300\text{V}$ $I_C = 400\text{A}$	$T_j = 25^\circ\text{C}$	2		mJ
$E_{off}$	Turn off Energy	$R_G = 1.8\Omega$	$T_j = 150^\circ\text{C}$	3.6		
			$T_j = 25^\circ\text{C}$	11.5		
$I_{sc}$	Short Circuit data	$V_{GE} \leq 15\text{V}$ ; $V_{Bus} = 360\text{V}$ $t_p \leq 6\mu\text{s}$ ; $T_j = 150^\circ\text{C}$	$T_j = 150^\circ\text{C}$	2000		A
$R_{thJC}$	Junction to Case Thermal Resistance				0.13	$^\circ\text{C/W}$

**CR1 to CR4 diode ratings and characteristics (per diode)**

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					650	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =650V				150	μA
I <sub>F</sub>	DC Forward Current		T <sub>c</sub> = 80°C		300		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 300A V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C		1.6	2	V
			T <sub>j</sub> = 150°C		1.5		
t <sub>rr</sub>	Reverse Recovery Time		T <sub>j</sub> = 25°C		130		ns
			T <sub>j</sub> = 150°C		225		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 300A V <sub>R</sub> = 300V di/dt = 4000A/μs	T <sub>j</sub> = 25°C		13.7		μC
			T <sub>j</sub> = 150°C		29		
E <sub>rr</sub>	Reverse Recovery Energy		T <sub>j</sub> = 25°C		3.2		mJ
			T <sub>j</sub> = 150°C		7		
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.29	°C/W

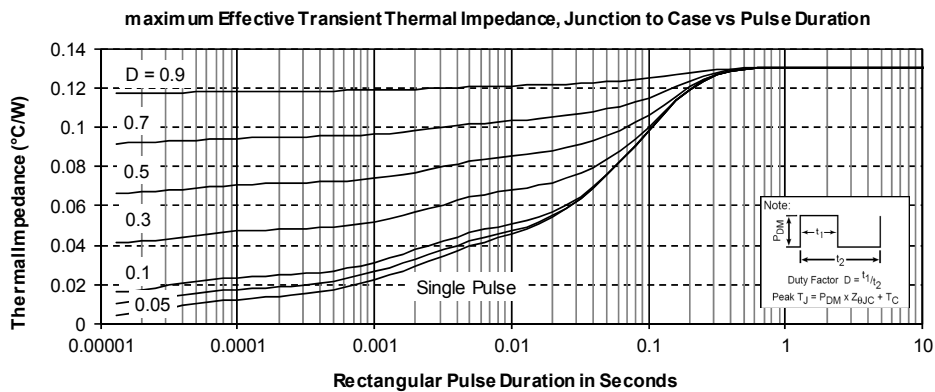
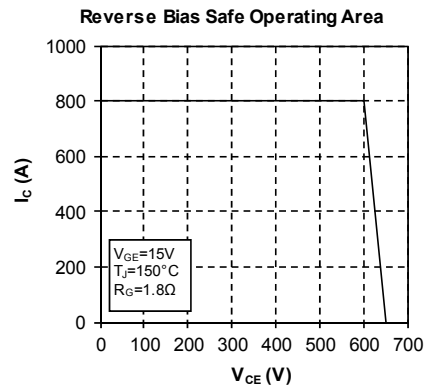
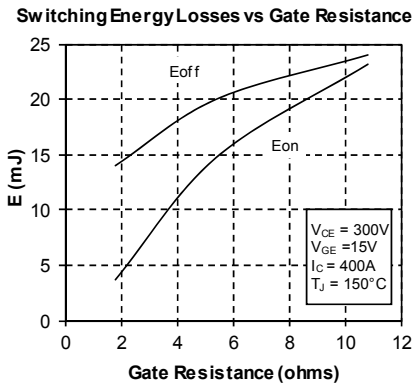
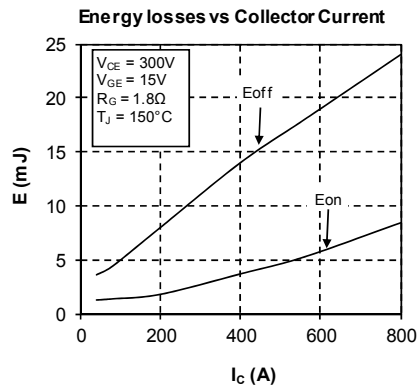
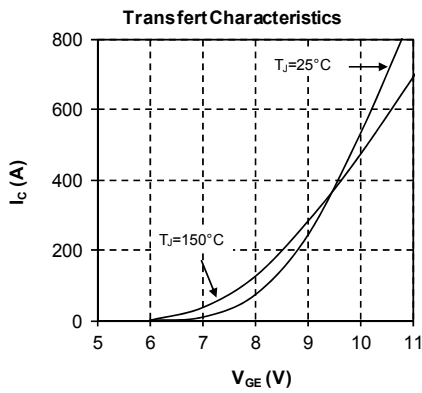
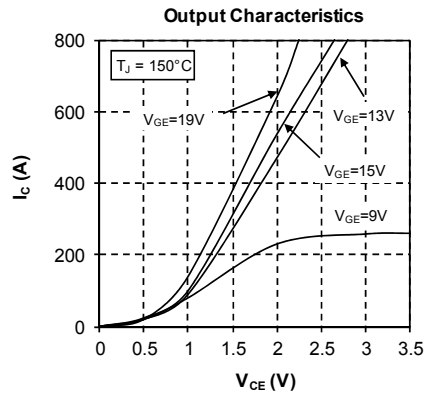
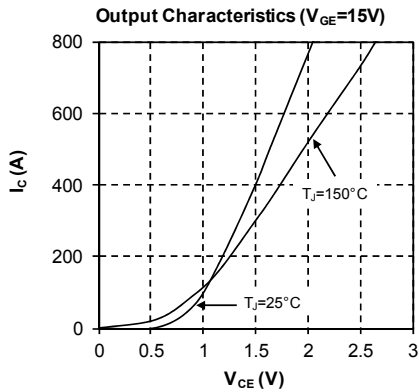
**CR5 & CR6 diode ratings and characteristics (per diode)**

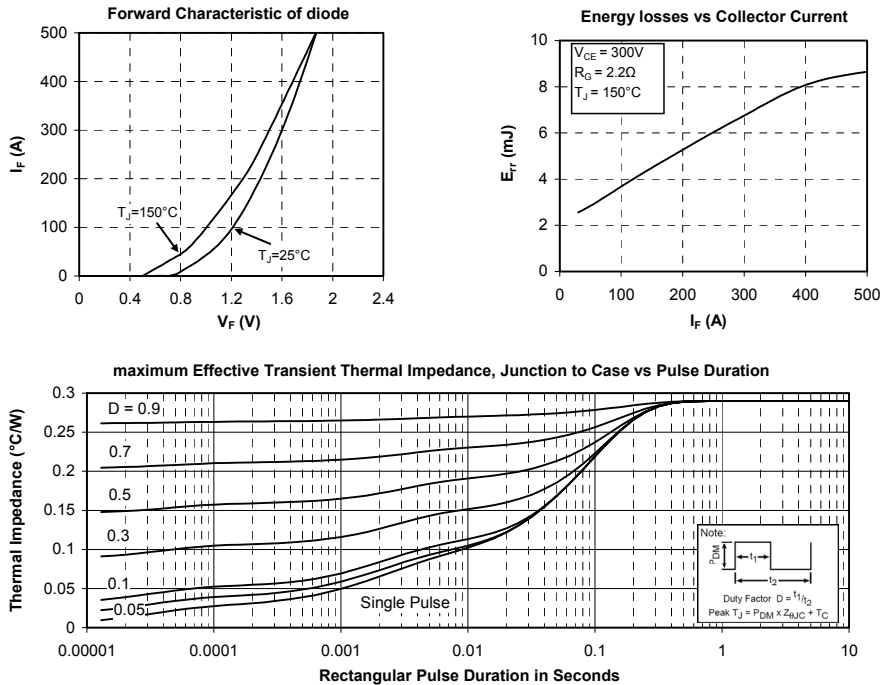
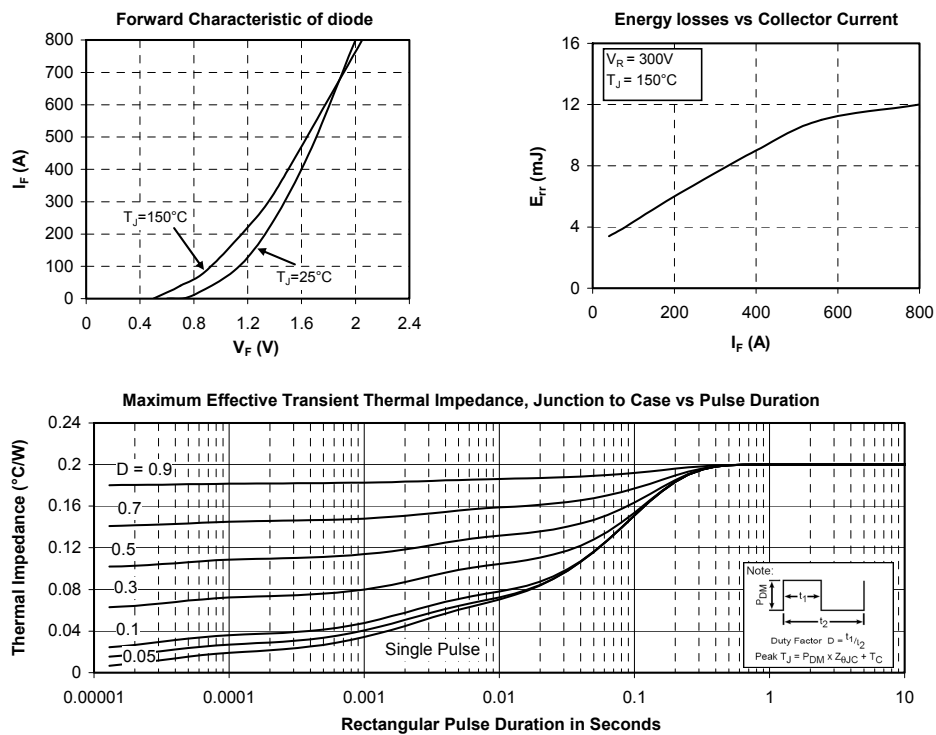
<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					650	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =650V				150	μA
I <sub>F</sub>	DC Forward Current		T <sub>c</sub> = 80°C		400		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 400A V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C		1.6	2.0	V
			T <sub>j</sub> = 150°C		1.5		
t <sub>rr</sub>	Reverse Recovery Time		T <sub>j</sub> = 25°C		125		ns
			T <sub>j</sub> = 150°C		220		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 400A V <sub>R</sub> = 300V di/dt = 4800A/μs	T <sub>j</sub> = 25°C		19		μC
			T <sub>j</sub> = 150°C		40		
E <sub>rr</sub>	Reverse Recovery Energy		T <sub>j</sub> = 25°C		4.4		mJ
			T <sub>j</sub> = 150°C		9.6		
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.2	°C/W

**Thermal and package characteristics**

<i>Symbol</i>	<i>Characteristic</i>			<i>Min</i>	<i>Max</i>	<i>Unit</i>
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz			4000		V
T <sub>J</sub>	Operating junction temperature range			-40	175	°C
T <sub>JOP</sub>	Recommended junction temperature under switching conditions			-40	T <sub>Jmax</sub> - 25	
T <sub>STG</sub>	Storage Temperature Range			-40	125	
T <sub>C</sub>	Operating Case Temperature			-40	100	
Torque	Mounting torque	To heatsink	M6	3	5	N.m
		For terminals	M5	2	3.5	
Wt	Package Weight				300	g





**CR1 to CR4 Typical performance curve**

**CR5 & CR6 Typical performance curve**


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